

| Application/Control N | No. Applicant(s)/Patent un Reexamination | nder |
|-----------------------|--|------|
| 10/666,470 | VISWESWARIAH, CHANDRAMOULI | |
| Examiner | Art Unit | |
| Sun J. Lin | 2825 | |

| SEARCHED | | | | |
|----------|----------|-----------|----------|--|
| Class | Subclass | Date | Examiner | |
| 716 | 6 | 2/15/2006 | JSL | |
| 716 | 4 | 2/15/2006 | JSL | |
| 716 | 5 | 2/15/2006 | JSL | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |

| INTERFERENCE SEARCHED | | | | |
|-----------------------|----------|------|----------|--|
| Class | Subclass | Date | Examiner | |
| | | | | |
| | | | | |
| | | L | | |
| | ļ | | | |
| | | | | |
| | | | | |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | |
|--|-----------|------|--|
| | DATE | EXMR | |
| EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB] | 2/15/2006 | JSL | |
| IEEE | 2/15/2006 | JSL | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |